

<b>Notice of References Cited</b>	Application/Control No. 10/709,379	Applicant(s)/Patent Under Reexamination HWANG ET AL.	
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0242289	12-2004	Jellicoe et al.	455/575.1
*	B	US-2003/0096583	05-2003	Watanabe, Hiroshi	455/90
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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